

Joint ICTP-IAEA Advanced Workshop on Portable X-Ray Spectrometry
Techniques for Characterization of Valuable Archaeological/Art Objects |
(smr 3298)

Contribution ID : 50

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Lecture 26: Characterization of glass and enamel using micro-XRF

Wednesday, 12 June 2019 15:45 (0:45)

Content

Summary

Presenter(s) : MIGLIORI, A. (IAEA); GRIESSER, M. (Kunsthistorisches Museum Vienna)

Session Classification : notitle